## Notice of References Cited Application/Control No. 10/594,243 Examiner Ngoc-Yen M. Nguyen Applicant(s)/Patent Under Reexamination WALSDORFF ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0172640	11-2002	Hibi et al.	423/502
*	В	US-2006/0233691	10-2006	Vanderspurt et al.	423/263
*	С	US-2008/0047872	02-2008	laccino et al.	208/066
*	D	US-4,137,706	02-1979	Clarke, John M.	60/39.12
*	Е	US-5,573,657	11-1996	Degnan et al.	208/144
	F	US-			
	O	US-			
	Ι	US-		1	
	_	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
6	R					
	s					
	I				100	

## **NON-PATENT DOCUMENTS**

*	-	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.